

Sheet 1 of 1

FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.: FIS920010192US1	SERIAL NO.: 09/977,793
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: Christopher P. Ausschnitt et al.	
(Use several sheets if necessary) (37 CFR 1.98(b))		FILING DATE: 10/15/01	GROUP: 2877

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
<i>WD</i>	AA	5,545,593	08/13/96	Watkins et al.	—	—	
	AB	5,877,861	03/02/99	Ausschnitt et al.	—	—	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

FOREIGN PATENT DOCUMENTS

			PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION	
	AM	DOCUMENT NUMBER					YES	NO
	AN							
	AO							
	AP							
	AQ							

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	
	ARS	
	AT	
EXAMINER	<i>William Davis</i>	DATE CONSIDERED <i>5-23-03</i>
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance <u>and</u> not considered. Include copy of this form with next communication to applicant.		

Sheet 1 of 3

FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.: FIS920010192US1	SERIAL NO.: 09/977,793
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: Christopher P. Ausschnitt et al.	
(Use several sheets if necessary) (37 CFR 1.98(b))		FILING DATE: October 15, 2001	GROUP: 2877

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
WD	AA	4,568,189	2/4/86	Bass et al.			
	AB	4,898,911	7/18/89	Uchida et al.			
	AC	5,343,292	8/30/94	Brueck et al.			
	AD	5,545,593	8/13/96	Watkins et al.			
	AE	5,629,772	5/13/97	Ausschnitt			
	AF	5,712,707	1/27/98	Ausschnitt et al.			
	AG	5,731,877	3/24/98	Ausschnitt			
	AH	5,756,242	5/26/98	Koizumi et al.			
	AI	5,757,507	5/26/98	Ausschnitt et al.			
	AJ	5,776,645	7/7/98	Barr et al.			
	AK	5,790,254	8/4/98	Ausschnitt			
	AL	5,805,290	9/8/98	Ausschnitt et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION YES NO
	AM	JP10-213895 A	8/11/98	Japan			
	AN	JP61-168227 A (Abstract only)	7/29/86	Japan			
	AO	JP61-170032 A (Abstract only)	7/31/86	Japan			
	AP	JP2-260441 A (Abstract only)	10/23/90	Japan			

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

	AQ	Starikov, Alexander, "Exposure Monitor Structure", SPIE Vol. 1261, Integrated Circuit Metrology, Inspection and Process Control IV, 1990, pages 315-324.
	AR	"Method for Measuring Semiconductor Lithographic Tool Focus and Exposure", IBM Technical Disclosure Bulletin, July 1987, pages 516-518.
	AS	

EXAMINER

W.D. Davis

DATE CONSIDERED

5-23-03

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Sheet 2 of 3

FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.: FIS920010192US1	SERIAL NO.: 09/977,793
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: Christopher P. Ausschnitt et al.	
(Use several sheets if necessary) (37 CFR 1.98(b))		FILING DATE: October 15, 2001	GROUP: 2877

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
WD	AT	5,877,861	3/2/99	Ausschnitt et al.			
	AU	5,914,784	6/22/99	Ausschnitt et al.			
	AV	5,928,822	7/27/99	Rhyu			
	AW	5,949,547	9/7/99	Tseng et al.			
	AX	5,952,134	9/14/99	Hwang			
	AY	5,953,128	9/14/99	Ausschnitt et al.			
	AZ	5,965,309	10/12/99	Ausschnitt et al.			
	BA	5,968,693	10/19/99	Adams			
	BB	5,976,740	11/2/99	Ausschnitt et al.			
	BC	5,981,119	11/9/99	Adams			
	BD	5,985,495	11/16/99	Okumura et al.			
	BE	6,003,223	12/21/99	Hagen et al.			

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FOREIGN PATENT DOCUMENTS								
			PUBLICATION	COUNTRY OR		SUB-	TRANSLATION	
		DOCUMENT NUMBER	DATE	PATENT OFFICE	CLASS	CLASS	YES	NO
	BF							
	BG							
	BH							

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

BI	
BJ	
BK	
EXAMINER	DATE CONSIDERED
Willie Davis	5-23-03
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Sheet 3 OF 3

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary) (37 CFR 1.98(b))	ATTY. DOCKET NO.: FIS920010192U51	SERIAL NO.: 09/977,793
	APPLICANT: Christopher P. Ausschnitt et al.	
	FILING DATE: October 15, 2001	GROUP: 2877

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
UD	BL	6,004,706	12/21/99	Ausschnitt et al.			
	BM	6,020,966	2/1/00	Ausschnitt et al.			
	BN	6,027,842	2/22/00	Ausschnitt et al.			
	BO	6,042,976	3/28/00	Chiang et al.			
	BP	6,128,089	10/3/00	Ausschnitt et al.			
	BQ	6,130,750	10/10/00	Ausschnitt et al.			
	BR	6,137,578	10/24/00	Ausschnitt			
	BS	6,183,919	2/6/01	Ausschnitt et al.			
	BT	6,317,211	11/13/01	Ausschnitt et al.			
	BU	6,346,979	2/12/02	Ausschnitt et al.			
	BV						
	BW						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
	BX							
	BY							
	BZ							
	CA							
	CB							

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

	CC	
	CD	
	CE	

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